

Available online at www.sciencedirect.com



PHYSICS LETTERS A

Physics Letters A 310 (2003) 95-100

www.elsevier.com/locate/pla

Simple optical measurement of the overlap and fidelity of quantum states

Martin Hendrych^a, Miloslav Dušek^b, Radim Filip^b, Jaromír Fiurášek^{b,*}

^a Joint Laboratory of Optics, Palacký University and the Physical Institute of the Czech Academy of Sciences, 17. listopadu 50, 772 00 Olomouc, Czech Republic

^b Department of Optics, Palacký University, 17. listopadu 50, 772 00 Olomouc, Czech Republic

Received 17 December 2002; received in revised form 17 December 2002; accepted 10 February 2003

Communicated by P.R. Holland

Abstract

We present the experimental results of a direct measurement of the overlap of both pure and mixed polarization states of photons. The fidelity and purity of mixed states were also measured. The experimental apparatus exploits the fact that a beam splitter can distinguish the singlet Bell state from the other Bell states, i.e., it realizes projections into the symmetric and antisymmetric subspaces of photons' Hilbert space.

© 2003 Elsevier Science B.V. All rights reserved.

PACS: 03.65.-w; 03.67.-a

Keywords: Fidelity; Bell measurement; Parametric down-conversion

Recently it was theoretically shown by several authors that many important characteristics of quantum states such as the purity, overlap, and fidelity can be measured directly [1,2] without carrying out a complete quantum-state reconstruction. However, the proposed experimental setups were rather complicated. They involved cavity QED, nonlinear optics, etc. The only reported experimental test is based on NMR [3]. In this Letter we show that for two qubits, encoded into the polarization states of photons, the same goal can be achieved with a simple beam splitter. Besides,

Corresponding author. *E-mail address:* fiurasek@optics.upol.cz (J. Fiurášek). the same setup with a beam splitter can serve as the recently proposed [4] universal measurement device programmed by a quantum state (where the polarization of one photon is measured, while the polarization state of the other photon serves as the "program" and determines the measurement basis).

Let us consider a flip operator *V* in the Hilbert space $\mathcal{H} \otimes \mathcal{H}$ of two distinguishable but equivalent subsystems: $V|\psi\rangle \otimes |\phi\rangle = |\phi\rangle \otimes |\psi\rangle$. Let us further consider a factorable state $\rho_A \otimes \rho_B$ in the same Hilbert space. Then it follows from a direct calculation that $\operatorname{Tr}(V\rho_A \otimes \rho_B) = \operatorname{Tr}(\rho_A \rho_B) \equiv F$; note that $\rho_A \rho_B$ is not a direct product. Taking into account the relation $V = \Pi^+ - \Pi^-$, where Π^+ and Π^- are projectors to the symmetric and antisymmetric subspaces of $\mathcal{H} \otimes \mathcal{H}$,

0375-9601/03/\$ – see front matter $\hfill \ensuremath{\mathbb{C}}$ 2003 Elsevier Science B.V. All rights reserved. doi:10.1016/S0375-9601(03)00262-7

respectively, one finally obtains

$$\operatorname{Tr}(\rho_{\mathrm{A}}\rho_{\mathrm{B}}) = \operatorname{Tr}(\Pi^{+}\rho_{\mathrm{A}}\otimes\rho_{\mathrm{B}}) - \operatorname{Tr}(\Pi^{-}\rho_{\mathrm{A}}\otimes\rho_{\mathrm{B}}). (1)$$

It means that if we were able to implement projections to the symmetric and antisymmetric subspaces we could measure the overlap of two general states living in \mathcal{H} . In particular, we would be able to measure the overlap of two pure states, $|\langle \psi | \phi \rangle|^2$, the fidelity $\langle \psi | \rho | \psi \rangle$ comparing the state ρ with the "original" state $| \psi \rangle$, and also to calculate the Hilbert–Schmidt distance of two general states:

$$d(\rho_{\rm A}, \rho_{\rm B}) = \left[\frac{1}{2}\,{\rm Tr}(\rho_{\rm A} - \rho_{\rm B})^2\right]^{1/2}.$$
 (2)

Besides, having a device realizing projective measurement { Π^+ , Π^- }, we could experimentally implement the simplest version of a quantum "multimeter" controlled by quantum "software" that has been proposed in Ref. [4]. In this concept, one qubit (the "program") determines the measurement basis for a projective measurement on the other qubit. Of course, any such measurement can be realized only approximately (with some error-rate). It has been shown [4] that under given conditions, the optimal multimeter that maximizes the average fidelity is represented by a projective measurement on the "program" and "data" together. This measurement is described exactly by projectors to the symmetric and antisymmetric subspaces of the "program-data" Hilbert space.

Now let us turn our attention to the polarization states of two photons. The states corresponding to the horizontal and vertical linear polarizations will be denoted as $|H\rangle$ and $|V\rangle$, respectively. In such a case the projector into the antisymmetric subspace has the following form $\Pi^- = |\Psi^-\rangle\langle\Psi^-|$, where

$$|\Psi^{-}\rangle = \frac{1}{\sqrt{2}} (|H\rangle_{1}|V\rangle_{2} - |V\rangle_{1}|H\rangle_{2})$$
(3)

is nothing else but a singlet state [5]. What happens if a singlet impinges on a beam splitter? It is an elementary exercise to show that a beam splitter transforms it to the state $(|H\rangle_3|V\rangle_4 - |V\rangle_3|H\rangle_4)/\sqrt{2}$ (the labeling of the inputs and outputs of the beam splitter is shown in Fig. 1). Such a state results in a simultaneous detection at both detectors placed in modes 3 and 4 [6–10].

The singlet is the only one of the four Bell states (completing the basis in the Hilbert space of two qubits) that produces such a coincidence detection.



Fig. 1. Setup of the experiment. NLX—nonlinear crystal, HWP—half-wave plates, F—long-wave pass filters (cut-off at 670 nm), L—lenses, PoC—polarization controller, C—fiber coupler, D—detectors.

The other Bell states make only one of the detectors fire. This fact makes the measurement on two qubits consisting of projectors Π^+ and Π^- experimentally feasible. The beam splitter can be seen as a universal quantum device suitable for the experimental realization of all the tasks discussed above.

The experimental setup is shown in Fig. 1. A Kr⁺ion laser of wavelength 413.1 nm illuminates a 10mm-long nonlinear crystal of LiIO₃ (cut $\theta = 90^{\circ}$, $\phi = 0^{\circ}$), where spontaneous parametric noncollinear degenerate type-I down-conversion occurs. After passing through the respective half-wave plates (HWP), the down-converted photons are coupled into optical fibers and combined at a fused 50/50 fiber coupler, thus forming a Hong-Ou-Mandel interferometer [11]. Since optical fiber deforms polarization states, one of the arms of the interferometer contains a polarization controller to match the polarizations of signal and idler beams at the coupler. The polarization controller consists of several loops of fiber acting as a set of a halfwave plate and two quarter-wave plates. Single-photon counting modules (employing silicon avalanche photodiodes with quantum efficiency $\eta = 51\%$) are placed at the output ports of the coupler and electronics measure their coincidence rate. With this setup, visibilities exceeding 98% were reached. Higher visibilities could not be reached due to the fact that the splitting ratio of the fiber coupler was not exactly 50/50 and due to the imperfections of the half-wave plates. A typical Hong-Ou-Mandel dip is shown in Fig. 2. Different time delays were generated by moving the coupling lens L2 and the tip of the fiber towards the nonlinear crystal. Moving the coupling stage 200 µm away from the center of the dip also served to measure the coincidence



Fig. 2. Hong-Ou-Mandel dip.

rate C_{200} on the shoulder for normalization purposes (it represents a half of the impinging-pair rate). According to Eq. (1) the overlap is calculated from measured data as follows:

$$\operatorname{Tr}(\rho_{A}\rho_{B}) = 1 - 2\operatorname{Tr}(\Pi^{-}\rho_{A}\otimes\rho_{B}) = 1 - \frac{C_{0}}{C_{200}},$$
 (4)

where C_0 is a coincidence rate when the arms of the interferometer are balanced.

Each data point at presented plots has been derived from 50–200 one-second measurement periods. On average, 3300 coincidences per second were measured on the shoulder away from the dip. Statistical errors are smaller than the symbols of points in the graphs. Other errors stem from the nonunit visibility and optical-path fluctuations. The accuracy of polarization-angle settings was better than $\pm 0.3^{\circ}$.

The main results of this Letter are shown in Figs. 3–6. First we measured the overlap of two pure states. Generated downconverted photon pairs were linearly polarized in the vertical direction. The polarization of photons in Arm 1 was kept fixed and the polarization angle θ of photons in Arm 2 was varied by rotating the half-wave plate HWP2. Thus we measured the overlap between the states $|V\rangle$ and $\cos \theta |V\rangle + \sin \theta |H\rangle$. The experimental results shown in Fig. 3 are in very good agreement with the theoretically expected dependence $\cos^2 \theta$ that is also plotted in Fig. 3.

In the next round of the measurements we simultaneously changed the polarization states of both photons by rotating both half-wave plates. In the first



Fig. 3. Overlap of two pure states. The first photon is in the state with vertical linear polarization ($\theta = 0$). The other photon is also linearly polarized but its polarization is rotated by angle $\theta > 0$.



Fig. 4. Overlap of two pure states (5) with $\vartheta = \theta$ (squares) and $\vartheta = \theta + \pi/2$ (triangles); θ is the polarization angle of the photon in Arm 1, ϑ is the polarization angle of the photon in Arm 2.

arrangement, both photons were linearly polarized in the same direction θ after passing through the halfwave plates and one would expect the overlap to be equal to one for all θ . In the second arrangement the two photons were linearly polarized in perpendicular directions, hence their polarization states were orthogonal and the theory predicts F = 0 for all θ .

However, a different behavior was observed—see Fig. 4. The dependence of the overlap on angle θ can be explained by the modification of the polarization state inside the fibers due to birefringence and other effects. This effect must be compensated for by the



Fig. 5. Measurement of the fidelity of a mixed state with respect to two different pure states $|V\rangle$ and $|A\rangle$. The full lines represent theoretical values.



Fig. 6. Measurement of the purity of mixed state (7)—circles. The full line represents the theoretical prediction $P = (1 + p^2)/2$. The triangles denote the eigenvalues of corresponding density matrices, calculated from the purity.

polarization controller whose proper setting should ensure that if the two photons enter the fibers in the identical polarization states, then they also arrive at the fiber coupler in identical polarization states. It is relatively easy to satisfy this condition for some chosen basis states, say $|H\rangle$ and $|V\rangle$, for which the visibility of the dip is tuned to maximum by manipulating the polarization controllers; however, this does not guarantee that the above condition will be satisfied for *any* polarization state. What happens in the fibers is that the horizontally polarized photon acquires certain nonzero phase shift with respect to the vertically polarized one. This shift is different, in general, for the fiber in Arm 1 and Arm 2. Therefore, the polarization of the two photons at the coupler is not the same even if the input polarization states are identical. However, this phase shift does not play any role if at least one of the photons is in the basis state $|H\rangle$ or $|V\rangle$. Due to the technical difficulties with the fiber polarization controller, we were not able to compensate for such phase shifts. The phenomenon can be described by an effective phase shift ϕ of one of the input polarization states. In our setup, we thus effectively prepare the following polarization states of photons,

$$|\psi_1\rangle = e^{i\phi}\cos\theta |V\rangle + \sin\theta |H\rangle,$$

$$|\psi_2\rangle = \cos\vartheta |V\rangle + \sin\vartheta |H\rangle,$$

(5)

where θ and ϑ are controlled by rotating the half-wave plates, and the fixed phase shift ϕ is a parameter of our apparatus. The outcomes of measurements with $\vartheta = \theta$ and $\vartheta = \theta + \pi/2$ are shown in Fig. 4. The formulas for the overlaps read:

$$F_{\parallel} = 1 - \sin^{2}(2\theta) \sin^{2}(\phi/2),$$

$$F_{\perp} = \sin^{2}(2\theta) \sin^{2}(\phi/2).$$
(6)

The solid lines in Fig. 4 display the best fits of the form $A + B \sin^2(2\theta)$, with $A_{\perp} = 0$, $B_{\perp} = 0.112$, $A_{\parallel} = 0.992$, and $B_{\parallel} = -0.107$. A very good agreement between the theory (6) and experimental data is observed. From the fit we can extract the absolute value of the phase shift, $|\phi| = 39.4^{\circ} \pm 0.3^{\circ}$.

So far we have focused on the overlap of two pure states. Our device can also be used to measure the fidelity of a mixed state with respect to a pure state or the overlap of two mixed states. The mixed state ρ was created as a mixture of three pure states $|V\rangle$, $|X\rangle$ and $|Y\rangle$,

$$\rho = p|V\rangle\langle V| + \frac{1-p}{2} (|X\rangle\langle X| + |Y\rangle\langle Y|), \tag{7}$$

where $|X\rangle$ and $|Y\rangle$ stand for two mutually orthogonal polarization states. In the experiment, states $|X\rangle$ and $|Y\rangle$ were generated by setting $\theta = 45^{\circ}$ and $\theta = -45^{\circ}$, respectively. The measured dependence of the fidelity $F = \langle \psi | \rho | \psi \rangle$ on the parameter *p* is shown in Fig. 5 for two different pure states $|V\rangle$ and $|A\rangle = (|V\rangle + |H\rangle)/\sqrt{2}$. Let us now turn our attention to the overlap of two mixed states. A particularly interesting case occurs if $\rho_A = \rho_B = \rho$ because the overlap is then equal to the purity of ρ , $\text{Tr}(\rho_A \rho_B) = \text{Tr}(\rho^2)$. To demonstrate this, we prepared both photons in the same mixed state (7) following the procedure described above. The measured purity is plotted in Fig. 6 as a function of p. If we know the purity P of the qubit state ρ , we can immediately determine the eigenvalues of ρ from the formula

$$\lambda_{1,2} = \frac{1}{2} (1 \pm \sqrt{2P - 1}). \tag{8}$$

Our experimental setup thus enables a direct estimation of the eigenvalues of ρ without the necessity to reconstruct the whole density matrix provided that two copies of ρ are available simultaneously for a joint measurement on $\rho \otimes \rho$. The obtained eigenvalues are plotted in Fig. 6. They are in good agreement with the theoretically expected behavior. The largest errors of eigenvalues occur when ρ is close to the maximally mixed state where $P \approx 1/2$ and a small error in *P* causes a large error in λ as can be deduced from Eq. (8). Note also that if we know the spectrum of ρ , then we can determine several important characteristics of ρ such as the von Neumann entropy $\text{Tr}(\rho \ln \rho) = \sum_{j=1}^{2} \lambda_j \ln \lambda_j$.

Finally, we experimentally determined the overlap of two different mixed states ρ_A and ρ_B of the form (7). The results for several different parameters p_A and p_B are summarized in Table 1. If we combine these data with the direct measurement of the purity of states ρ_A and ρ_B , we can calculate the Hilbert– Schmidt distance $d(\rho_A, \rho_B)$ from Eq. (2)—the results are also shown in Table 1.

As mentioned in the introduction, our experimental device can also serve as a "quantum multime-

Table 1

Measured overlap F and Hilbert–Schmidt distance d of two mixed states. The columns labeled by F_{th} and d_{th} show the theoretical values for comparison

$p_{\rm A}$	$p_{\rm B}$	F	F _{th}	d	d_{th}
0.2	0.4	0.545	0.540	0.097	0.100
0.2	0.6	0.563	0.560	0.197	0.200
0.2	0.8	0.581	0.580	0.298	0.300
0.4	0.6	0.621	0.620	0.096	0.100
0.4	0.8	0.658	0.660	0.201	0.200
0.6	0.8	0.736	0.740	0.099	0.100

Table 2 Fidelity of the quantum multimeter for three different polarization angles θ

θ	0°	45°	90°
F	0.749	0.694	0.747

ter" [4]. The polarization state of one input photon, $|\psi\rangle$, represents a program (it determines the measurement basis spanned by $|\psi\rangle$ and its orthogonal counterpart $|\psi_{\perp}\rangle$). The other input photon represents the measured qubit (in some "unknown" state $|\varphi\rangle$). A coincident detection corresponds to the measurement result "one", a detection at only one of the detectors corresponds to the measurement result "two". The probabilities of the results "one" and "two", respectively, read: $p_{\perp,\parallel}(\psi,\varphi) = [1 \mp |\langle \psi | \varphi \rangle|^2]/2$. Of course, in reality the performance of the multimeter is impaired by the low detection efficiency. Nevertheless, we can still verify the predicted fidelity of such a multimeter. It is given by the formula [4]

$$F(\psi) = \frac{1}{2} \Big[p_{\parallel}(\psi, \psi) + p_{\perp}(\psi, \psi_{\perp}) \Big].$$
(9)

As we can measure the overlaps, we can also determine this function. For the three program states of the form $\cos \theta |V\rangle + \sin \theta |H\rangle$, the corresponding fidelities are shown in Table 2. The deviation from the theoretical value 3/4 for the case of 45° linear polarization is mainly due to the noncompensated phase shift ϕ in the fiber.

Acknowledgements

This research was supported by the Ministry of Education of the Czech Republic, projects LN00A015 and RN19982003012.

References

- [1] R. Filip, Phys. Rev. A 65 (2002) 062320.
- [2] A.K. Ekert, et al., Phys. Rev. Lett. 88 (2002) 217901.
- [3] X. Fei, D. Jiangfeng, W. Jihui, Z. Xianyi, H. Rongdian, quantph/0204049.
- [4] J. Fiurášek, M. Dušek, R. Filip, Phys. Rev. Lett. 89 (2002) 190401.
- [5] S.M. Barnett, A. Chefles, I. Jex, Phys. Lett. A 307 (2003) 189.
- [6] H. Weinfurter, Europhys. Lett. 25 (1994) 559.
- [7] S.L. Braunstein, A. Mann, Phys. Rev. A 51 (1995) R1727.

- [8] M. Michler, K. Mattle, H. Weinfurter, A. Zeilinger, Phys. Rev. A 53 (1996) R1209.
- [9] K. Mattle, H. Weinfurter, P.G. Kwiat, A. Zeilinger, Phys. Rev. Lett. 76 (1996) 4656.
- [10] D. Bouwmeester, J.W. Pan, K. Mattle, M. Eibl, H. Weinfurter, A. Zeilinger, Nature (London) 390 (1997) 575.
- [11] C.K. Hong, Z.Y. Ou, L. Mandel, Phys. Rev. Lett. 59 (1987) 2044.